Extended Data

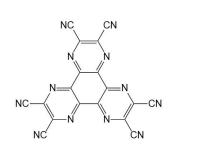
Operational stability enhancement in organic light emitting diodes with ultrathin Liq interlayers

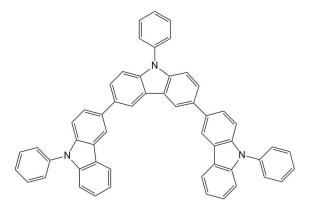
¹Daniel Ping-Kuen Tsang and ^{1,2}Chihaya Adachi

¹Center for Organic Photonics and Electronics Research (OPERA), Kyushu University, 744 Motooka,

Nishi, Fukuoka 819-0395, Japan

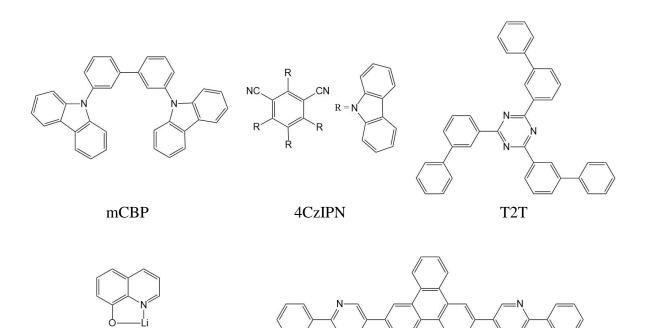
²JST, ERATO, Adachi Molecular Exciton Engineering Project, Kyushu University, 744 Motooka, Nishi, Fukuoka 819-0395, Japan





HAT-CN

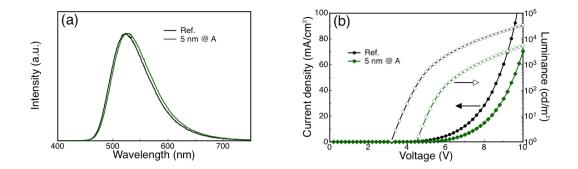
Tris-PCz

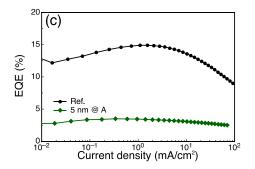


Liq

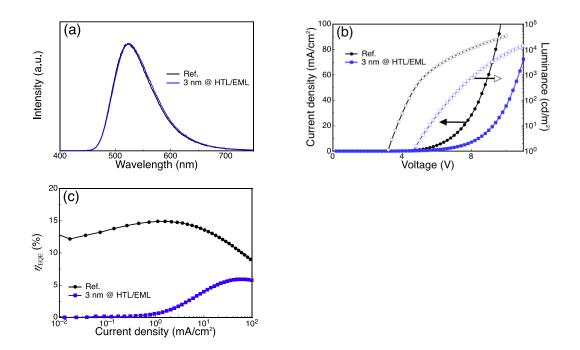


Extended Data Figure 1 | Chemical structures of materials in the tested devices.

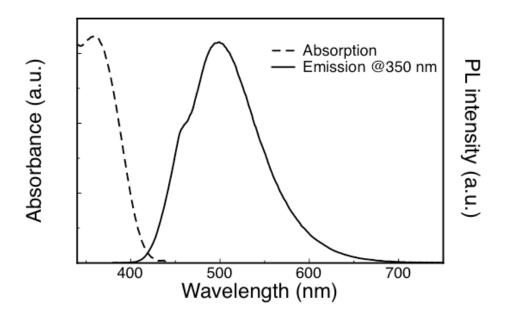




Extended Data Figure 2 | The electroluminescence characteristics of the reference device (Ref.) and a device with a 5-nm-thick Liq interlayer at position A. a, Electroluminescence spectra at 10 mA/cm². b, Luminance (empty symbols) and current density (filled symbols) as a function of voltage. c, External quantum efficiency vs. current density characteristics.

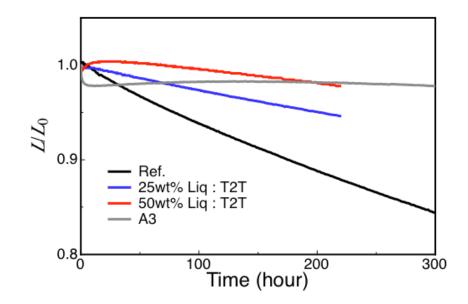


Extended Data Figure 3 | The electroluminescence characteristics of the reference device (Ref.) and a device with a 3-nm-thick Liq interlayer between the HTL and EML. a, Electroluminescence spectra at 10 mA/cm². b, Luminance (empty symbols) and current density (filled symbols) as a function of voltage. c, External quantum efficiency vs. current density characteristics.

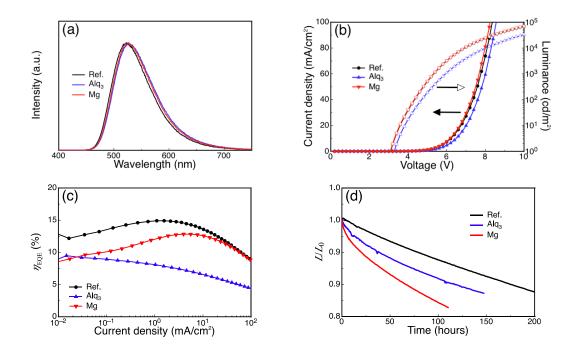


Extended Data Figure 4 | The absorption and photoluminescence spectra of Liq film excited

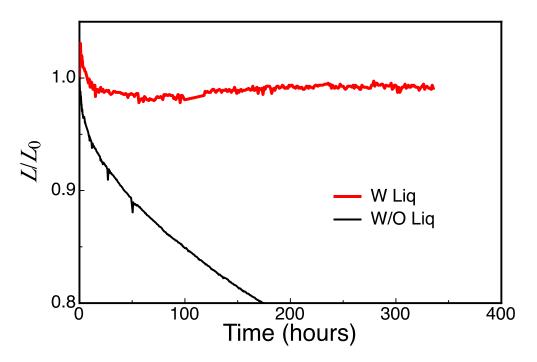
by a 350 nm light source.



Extended Data Figure 5 | Luminance vs. operating time at a fixed current density with an initial luminescence of 1,000 cd/m² for the reference device (Ref.) and devices with an HBL doped with Liq. The structure of the devices with the doped HBML was ITO / HAT-CN (10 nm) / Tris-PCz (30 nm) / 15 wt% 4CzIPN:mCBP (30 nm) / 25wt% Liq:T2T (blue) or 50wt% Liq:HBL (red) / Bpy-TP2 (40 nm) / LiF (0.8 nm) / A1 (100 nm).



Extended Data Figure 6 | The electroluminescence characteristics of a reference device (Ref.) and devices with a 3-nm-thick interlayer of either 3 nm Alq₃ or Mg at position A. a, Electroluminescence spectra at 10 mA/cm². b, Luminance (empty symbols) and current density (filled symbols) as a function of voltage. c, External quantum efficiency vs. current density characteristics. d, Luminance vs. operating time at a fixed current density with an initial luminescence of 1,000 cd/m².



Extended Data Figure 7 | Luminance vs. operating time at a fixed current density with an initial luminescence of 1,000 cd/m² for phosphorescent OLEDs with and without Liq. The device structure is ITO / HAT-CN (10 nm) / Tris-PCz (30 nm) / 8 wt% Ir(ppy)₃:mCBP (30 nm) / (red curve only) Liq (3 nm) / T2T (10 nm) / Bpy-TP2 (40 nm) / LiF (0.8 nm) / Al (100 nm).